

Asymptotics III: Bayes Inference and Large-Sample Tests

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Outline

- 1 Asymptotics of Bayes Posterior Distributions
 - Consistency of Posterior Distribution
 - Asymptotic Normality of Posterior Distribution
 - Mutual Optimality of Bayes and MLE Procedures
- 2 Large Sample Tests
 - Likelihood Ratio Tests
 - Wald's Large Sample Test
 - The Rao Score Test

Consistency of Posterior Distribution

Framework

- X_1, \dots, X_n iid $P_\theta, \theta \in \Theta$.
- Θ (open) $\subset R$ or $\Theta = \{\theta_1, \dots, \theta_k\}$ finite.
- Regular model with identifiable θ .

Consistency: Finite Θ

Posterior distribution of θ given $\mathbf{X}_n = (X_1, \dots, X_n)$:

$$\pi(\theta' | \mathbf{X}_n) \equiv P[\theta = \theta' | X_1, \dots, X_n], \theta' \in \Theta.$$

Definition: $\pi(\cdot | \mathbf{X}_n)$ is **consistent** if and only if for every $\theta' \in \Theta$,

$$P_{\theta'}[|\pi(\theta' | \mathbf{X}_n) - 1|] \geq \epsilon \rightarrow 0$$

for all $\epsilon > 0$.

Definition: $\pi(\cdot | \mathbf{X}_n)$ is **a.s. (almost surely) consistent** if and only if for every $\theta' \in \Theta$,

$$\pi(\theta' | \mathbf{X}_n) \xrightarrow{a.s. P_{\theta'}} 1.$$

Consistency of Posterior Distribution

Theorem 5.5.1 Let $\pi_j = P[\theta = \theta_j]$, $j = 1, \dots, k$ denote the prior distribution of θ . Then

$\pi(\cdot | \mathbf{X}_n)$ is consistent iff $\pi_j > 0$, for all $\pi_j \in \Theta$.

Proof:

- Let $p(x | \theta)$ denote the density/pmf function of a single X_i .
The posterior distribution is given by:

$$\begin{aligned}\pi(\theta_j | X_1, \dots, X_n) &= P[\theta = \theta_j | X_1, \dots, X_n] \\ &= \frac{\pi_j \prod_{i=1}^n p(X_i | \theta_j)}{\sum_{a=1}^k \pi_a \prod_{i=1}^n p(X_i | \theta_a)}\end{aligned}$$

If any $\pi_j = 0$, then $\pi(\theta_j | \mathbf{X}_n) = 0$ for all n ; i.e., the posterior is not consistent.

- Suppose all $\pi_j > 0$. For a fixed j , suppose θ_j is true, i.e., $\theta = \theta_j$.

We show that

$$\pi(\theta_j | \mathbf{X}_n) \longrightarrow 1 \text{ and } \pi(\theta_a | \mathbf{X}_n) \longrightarrow 0, \text{ for } a \neq j.$$

Consistency Theorem Proof

Proof (continued)Evaluate the log of the posterior odds to the true θ :

$$\begin{aligned}
 \log \left[\frac{\pi(\theta_a | \mathbf{X}_n)}{\pi(\theta_j | \mathbf{X}_n)} \right] &= \log \left[\frac{\pi_a \prod_{i=1}^n p(X_i | \theta_a)}{\pi_j \prod_{i=1}^n p(X_i | \theta_j)} \right] \\
 &= \log \left[\frac{\pi_a}{\pi_j} \right] + \log \left[\frac{\prod_{i=1}^n p(X_i | \theta_a)}{\prod_{i=1}^n p(X_i | \theta_j)} \right] \\
 &= \log \left[\frac{\pi_a}{\pi_j} \right] + \sum_{i=1}^n \log \left[\frac{p(X_i | \theta_a)}{p(X_i | \theta_j)} \right] \\
 &= n \left(\frac{1}{n} \log \left[\frac{\pi_a}{\pi_j} \right] + \frac{1}{n} \sum_{i=1}^n \log \left[\frac{p(X_i | \theta_a)}{p(X_i | \theta_j)} \right] \right) \\
 &\rightarrow n \left(0 + E \left[\log \left[\frac{p(X_1 | \theta_a)}{p(X_1 | \theta_j)} \right] \right] \right) \\
 &\rightarrow \begin{cases} 0 & \text{if } a = j \\ -\infty & \text{if } a \neq j \end{cases}
 \end{aligned}$$

(Shannon's Inequality gives $E \left[\log \left[\frac{p(X_1 | \theta_a)}{p(X_1 | \theta_j)} \right] \right] < 0$, for $a \neq j$)

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Asymptotic Normality of Posterior Distribution

Theorem 5.5.2 (“Bernstein/von Mises”).

- $\mathbf{X}_n = (X_1, \dots, X_n)$ where the X_i are iid P_{θ_0} , $\theta_0 \in \Theta$.
- $\hat{\theta}_n = \hat{\theta}_n(\mathbf{X}_n)$ is the MLE of θ_0
- Regularity conditions are satisfied such that
$$\sqrt{n}(\hat{\theta}_n - \theta_0) \xrightarrow{\mathcal{L}} N(0, I^{-1}(\theta_0)).$$
- The prior distribution on Θ has density $\pi(\cdot)$ which is continuous and positive at all $\theta' \in \Theta$.
- Consider the scaled version of the posterior distribution:

$$\mathcal{L}(\sqrt{n}(\theta - \hat{\theta}) | \mathbf{X}_n)$$

Under sufficient regularity conditions:

$$\mathcal{L}(\sqrt{n}(\theta - \hat{\theta}) | \mathbf{X}_n) \longrightarrow N(0, I^{-1}(\theta_0))$$

i.e.,

$$\pi(\sqrt{n}(\theta - \hat{\theta}) \leq x | \mathbf{X}_n) \longrightarrow \Phi(x\sqrt{I(\theta_0)})$$

Bernstein / Von Mises Theorem

Proof:

- To compute the asymptotic distribution of $\sqrt{n}(\theta - \hat{\theta}(\mathbf{X}_n))$, define

$$t = \sqrt{n}(\theta - \hat{\theta}(\mathbf{X}_n))$$

so that

$$\theta = \hat{\theta}(\mathbf{X}_n) + \frac{t}{\sqrt{n}}.$$

- The posterior density of t given \mathbf{X}_n is

$$\begin{aligned} q_n(t) &\propto \pi(\hat{\theta}(\mathbf{X}_n) + \frac{t}{\sqrt{n}}) \prod_{i=1}^n p(X_i | \hat{\theta}(\mathbf{X}_n) + \frac{t}{\sqrt{n}}) \\ &= c_n^{-1} \pi(\hat{\theta}(\mathbf{X}_n) + \frac{t}{\sqrt{n}}) \prod_{i=1}^n p(X_i | \hat{\theta}(\mathbf{X}_n) + \frac{t}{\sqrt{n}}) \end{aligned}$$

where $c_n = \int_{-\infty}^{\infty} \pi(\hat{\theta}(\mathbf{X}_n) + \frac{t}{\sqrt{n}}) \prod_{i=1}^n p(X_i | \hat{\theta}(\mathbf{X}_n) + \frac{t}{\sqrt{n}}) dt$.

- Divide numerator and denominator of $q_n(t)$ by

$$\prod_{i=1}^n p(X_i | \hat{\theta}(\mathbf{X}_n))$$

Bernstein / Von Mises Theorem

Proof (continued)

$$\begin{aligned}
 q_n(t) &= c_n^{-1} \pi(\hat{\theta}(\mathbf{X}_n) + \frac{t}{\sqrt{n}}) \prod_{i=1}^n p(X_i | \hat{\theta}(\mathbf{X}_n) + \frac{t}{\sqrt{n}}) \\
 &= c_n^{-1} \pi(\hat{\theta} + \frac{t}{\sqrt{n}}) \exp\{\sum_{i=1}^n \log(p(X_i | \hat{\theta} + \frac{t}{\sqrt{n}}))\} \\
 &= d_n^{-1} \pi(\hat{\theta} + \frac{t}{\sqrt{n}}) \exp\{\sum_{i=1}^n \ell(X_i | \hat{\theta} + \frac{t}{\sqrt{n}}) - \ell(X_i, \hat{\theta})\}
 \end{aligned}$$

where

$$d_n = \int_{-\infty}^{\infty} \pi(\hat{\theta} + \frac{t}{\sqrt{n}}) \exp\{\sum_{i=1}^n \ell(X_i | \hat{\theta} + \frac{t}{\sqrt{n}}) - \ell(X_i, \hat{\theta})\} dt$$

Claims

- $d_n q_n(t) \xrightarrow{P_{\theta_0}} \pi(\theta_0) \exp\{-\frac{t^2 I(\theta_0)}{2}\}$
- $d_n \xrightarrow{P_{\theta_0}} \pi(\theta_0) \int_{-\infty}^{\infty} \exp\{-\frac{s^2 I(\theta_0)}{2}\} ds = \frac{\pi(\theta_0) \sqrt{2\pi}}{\sqrt{I(\theta_0)}}$

which give:

$$q_n \xrightarrow{P_{\theta_0}} \sqrt{I(\theta_0)} \phi(t \sqrt{I(\theta_0)}).$$

Theorem follows by Scheffe's Theorem (B.7.6).

Limiting Posterior Distributions: Examples

Posterior Distribution of Normal Mean

- X_1, \dots, X_n iid $N(\theta_0, \sigma^2)$ with σ^2 known.
- Prior distribution: $\theta \sim N(\eta, \tau^2)$.
- Posterior distribution:

$$\pi(\theta | \mathbf{X}_n) = N(\eta_n, \tau_n^2),$$

where

$$\tau_n^{-2} = \tau^{-2} + \frac{n}{\sigma^2}$$

$$\eta_n = w_n \eta + (1 - w_n) \bar{X}, \text{ with } w_n = \frac{\sigma^2}{n\tau^2 + \sigma^2}$$

Note:

- $\eta_n \rightarrow \hat{\theta} = \bar{X}$, $\tau_n^2 \rightarrow 0$, and $\bar{X} \xrightarrow{P_{\theta_0}} \theta$, so

$$\pi(\theta | \mathbf{X}_n) \xrightarrow{P_{\theta_0}} \text{point-mass at } \theta = \theta_0.$$

- A posteriori,

$$\begin{aligned} \sqrt{n}(\theta - \hat{\theta}) &\sim N(\sqrt{n}w_n(\eta - \bar{X}), n(\frac{n}{\sigma^2} + \frac{1}{\tau^2})^{-1}) \\ &\rightarrow N(0, \mathbf{I}^{-1}(\theta_0)) = N(0, \sigma^2) \end{aligned}$$

Limiting Posterior Distributions: Examples

Posterior Distribution of Success Probability in Bernoulli Trials

- X_1, \dots, X_n iid *Bernoulli*(θ_0).
- $S_n = \sum_1^n X_i \sim \text{Binomial}(n, \theta_0)$.
- Prior distribution: $\theta \sim \text{Beta}(r, s)$.
- Posterior distribution $\theta \mid S_n \sim \text{Beta}(r^*, s^*)$,
where $r^* = S_n + r$, and $s^* = s + (n - S_n)$.
- By Problem 5.3.20, if $r^* \rightarrow \infty$ and $s^* \rightarrow \infty$ such that
 $r^*/(r^* + s^*) \rightarrow \theta_0 \in (0, 1)$, then the $\text{Beta}(r^*, s^*)$ r.v. θ :

$$P \left[\sqrt{r^* + s^*} \frac{(\theta - r^*/(r^* + s^*))}{\sqrt{\theta_0(1-\theta_0)}} \right] \rightarrow N(0, 1).$$

This is easily shown to be equivalent to

$$\sqrt{n}(\theta - \bar{X}) \xrightarrow{\mathcal{L}} N(0, \theta_0(1 - \theta_0)) = N(0, I^{-1}(\theta_0))$$

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Mutual Optimality of Bayes and MLE Procedures

Theorem 5.5.3 Under the conditions of the previous theorems, let $\hat{\theta}$ be the MLE of θ and let $\hat{\theta}^*$ be the median of the posterior distribution of θ . Then

(i). From a frequentist point of view, i.e., given P_θ :

$$\begin{aligned}\sqrt{n}(\hat{\theta}^* - \hat{\theta}) &\xrightarrow{a.s. P_\theta} 0, \text{ for all } \theta \\ \hat{\theta}^* &= \theta + \frac{1}{n} \sum_{i=1}^n I^{-1}(\theta) \frac{\partial \ell}{\partial \theta}(X_i, \theta) + o_{P_\theta}(n^{-1/2}) \\ \sqrt{n}(\hat{\theta}^* - \theta) &\xrightarrow{\mathcal{L}} N(0, I^{-1}(\theta)).\end{aligned}$$

(ii). From a Bayesian point of view, i.e., for $\pi(\theta | X_1, \dots, X_n)$:

$$E[\sqrt{n}(|\theta - \hat{\theta}| - |\theta - \hat{\theta}^*|) | X_1, \dots, X_n] = o_P(1), \text{ and}$$

$$\begin{aligned}E[\sqrt{n}(|\theta - \hat{\theta}| - |\theta|) | X_1, \dots, X_n] = \\ \min_d (E[\sqrt{n}(|\theta - d| - |\theta|) | X_1, \dots, X_n]) + o_P(1).\end{aligned}$$

Mutual Optimality of Bayes and MLE Procedures

Significant Results

- Bayes estimates for a wide variety of loss functions and priors are asymptotically efficient in the sense being asymptotically unbiased with minimum asymptotic variance.
- Maximum-likelihood estimates are asymptotically equivalent in a Bayesian sense to the Bayes estimate for a variety of priors and loss functions.

E.g., the Bayesian posterior median with $L(\theta, d) = |\theta - d|$,
the Bayesian posterior mean with $L(\theta, d) = |\theta - d|^2$.

Bayes Credible Regions

Theorem 5.5.4 Under the conditions of the previous theorems, consider

- The **Bayes Credible Region**:

$$C_n(X_1, \dots, X_n) = \{\theta : \pi(\theta | X_1, \dots, X_n) \geq c_n\},$$

where c_n is chosen so that $\pi(C_n | X_1, \dots, X_n) = 1 - \alpha$.

- For $\gamma : 0 < \gamma < 1$, the level $(1 - \gamma)$ **Asymptotically Optimal Interval Estimate** based on $\hat{\theta}$, given by

$$Interval_n(\gamma) = [\hat{\theta} - d_n(\gamma), \hat{\theta} + d_n(\gamma)]$$

where $d_n(\gamma) = [\Phi^{-1}(1 - \gamma/2)] \times \left(\frac{1}{\sqrt{n} \sqrt{[I(\theta_0)]}} \right)$.

Then, for every $\epsilon > 0$, and every θ :

$$P_\theta [Interval_n(\alpha + \epsilon) \subset C_n(X_1, \dots, X_n) \subset Interval_n(\alpha - \epsilon)] \rightarrow 1$$

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Likelihood Ratio Test

Likelihood Ratio Test Statistic

- $\mathbf{X}_n = (X_1, \dots, X_n)$ iid $P_\theta, \theta \in \Theta$.
- Testing null vs alternative hypotheses:
 $H : \theta \in \Theta_0$ vs $K : \theta \notin \Theta_0$.

- Likelihood ratio statistic:

$$\lambda(\mathbf{x}_n) = \frac{\sup_{\theta \in \Theta} p(\mathbf{x}_n | \theta)}{\sup_{\theta \in \Theta_0} p(\mathbf{x}_n | \theta)}$$

Standard transformation:

$$2 \log \lambda(\mathbf{x}_n) = 2[\ell_n(\hat{\theta} | \mathbf{x}_n) - \ell_n(\hat{\theta}_0 | \mathbf{x}_n)]$$

where $\hat{\theta}(\mathbf{x}_n)$ is the MLE (over all Θ) and $\hat{\theta}_0(\mathbf{x}_n)$ is the MLE under $H : \theta \in \Theta_0$.

Theorem 6.3.1 Given suitable assumptions (e.g. Theorem 6.2.2), if $\Theta \subset R^r$, and $H : \theta = \theta_0$ is true, then

$$2 \log \lambda(\mathbf{x}) = 2[\ell_n(\hat{\theta} | \mathbf{x}) - \ell_n(\theta_0)] \xrightarrow{\mathcal{L}} \chi_r^2,$$

Theorem 6.2.2 Proof

- By Theorem 6.2.2. Given suitable assumptions, the MLE $\hat{\theta}(\mathbf{x}_n)$ satisfies

$$\hat{\theta}(\mathbf{x}_n) = \theta + \frac{1}{n} \sum_{i=1}^n I^{-1}(\theta) D\ell(X_i, \theta) + o_P(n^{-1/2})$$

so that

$$\sqrt{n}(\hat{\theta}(\mathbf{x}_n) - \theta) \xrightarrow{\mathcal{L}} N(0, I^{-1}(\theta)).$$

- The Taylor expansion of $\ell_n(\theta)$ about $\hat{\theta}(\mathbf{x}_n)$ evaluated at $\theta = \theta_0$ gives

$$\begin{aligned} 2 \log \lambda(\mathbf{x}) &= 2[\ell_n(\hat{\theta} | \mathbf{x}) - \ell_n(\theta_0 | \mathbf{X})] \\ &= n(\hat{\theta}(\mathbf{x}_n) - \theta_0)^T I_n(\theta^*)(\hat{\theta}(\mathbf{x}_n) - \theta_0) \end{aligned}$$

where $I_n(\theta) = \left\| -\frac{1}{n} \sum_{i=1}^n \frac{\partial}{\partial \theta_k} \frac{\partial}{\partial \theta_j} \log p(X_i | \theta) \right\|$,

the $r \times r$ matrix: $I_n(\theta) \xrightarrow{\mathcal{P}_{\theta_0}} I(\theta_0)$

Theorem 6.2.2 Proof (continued)

- With $\mathbf{V} \sim N(0, \mathbf{I}^{-1}(\theta_0))$,
$$\begin{aligned}2 \log \lambda(\mathbf{x}) &= 2[\ell_n(\hat{\theta} \mid \mathbf{x}) - \ell_n(\theta_0 \mid \mathbf{X})] \\ &= n(\hat{\theta}(\mathbf{x}_n) - \theta_0)^T \mathbf{I}_n(\theta^*)(\hat{\theta}(\mathbf{x}_n) - \theta_0) \\ &\xrightarrow{\mathcal{L}} \mathbf{V}^T \mathbf{I}(\theta_0) \mathbf{V}\end{aligned}$$

and by Corollary B.6.2

$$\mathbf{V}^T \mathbf{I}(\theta_0) \mathbf{V} \sim \chi_r^2.$$

Theorem 6.3.2 Given suitable assumptions (e.g. Theorem 6.2.2), if $\Theta \subset R^r$, and $H : \theta \in \Theta_0$ with Θ_0 of dimension $q < r$, then

$$2 \log \lambda(\mathbf{x}) = 2[\ell_n(\hat{\theta} \mid \mathbf{x}) - \ell_n(\hat{\theta}_0 \mid \mathbf{X})] \xrightarrow{\mathcal{L}} \chi_{r-q}^2.$$

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The Wald Test

The asymptotic level- α Wald Test of the simple hypothesis

$$H : \theta = \theta_0 \text{ vs } K : \theta \neq \theta_0$$

rejects H when

$$W_n(\theta_0) = n(\hat{\theta}(\mathbf{x}_n) - \theta_0)^T \mathbf{I}(\theta_0)(\hat{\theta}(\mathbf{x}_n) - \theta_0) \geq C^*,$$

where the critical value C^* is such that $P(\chi_r^2 > C^*) = 1 - \alpha$.

- Under the assumptions of Theorem 6.2.2

$$\sqrt{n}(\hat{\theta}(\mathbf{x}_n) - \theta) \xrightarrow{\mathcal{L}} N(0, \mathbf{I}^{-1}(\theta)).$$

- By Slutsky's theorem:

$$n(\hat{\theta}(\mathbf{x}_n) - \theta)^T \mathbf{I}(\theta)(\hat{\theta}(\mathbf{x}_n) - \theta) \xrightarrow{\mathcal{L}} \mathbf{V}^T \mathbf{I}(\theta) \mathbf{V}$$

where $\mathbf{V} \sim N_r(0, \mathbf{I}^{-1}(\theta))$.

The Wald Test extends to apply to a composite null hypothesis $H : \theta \in \Theta_0 \subset R^q$. If the MLE $\hat{\theta}_0(\mathbf{x}_n)$ under the null is consistent, then it can replace θ_0 in the Wald Test statistic which is asymptotically χ_{r-q}^2 under H , where q is the dimensionality of Θ_0 .

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The Rao Score Test

- Simple hypothesis $H : \theta = \theta_0$.
- Apply the Central Limit Theorem to the maximum-likelihood contrast function, evaluated at $\theta = \theta_0$:

$$\psi_n(\theta_0) = \frac{1}{n} \sum_{i=1}^n D_{\theta} \ell_n(\theta_0) \xrightarrow{\mathcal{L}} N(0, I(\theta_0)),$$

when H is true.

- It follows that under H

$$R_n(\theta_0) = n \psi_n^T(\theta_0) I^{-1}(\theta_0) \psi_n(\theta_0) \xrightarrow{\mathcal{L}} \chi_r^2.$$

The asymptotic level- α Rao Score Test rejects H when

$$R_n(\theta_0) \geq C^*$$

where $C^* : P(\chi_r^2 > C^*) = 1 - \alpha$.

Notes:

- The Rao Score Test does not require the MLE!!
- Extension to composite null hypothesis H only requires MLE under H (see Theorem 6.3.5).

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